

**Notice of References Cited**

Application/Control No.

09/864,561

Applicant(s)/Patent Under  
Reexamination  
WONG, HEE

Examiner

Ronald Laneau

Art Unit

2674

Page 1 of 1

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	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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